

**General Description**

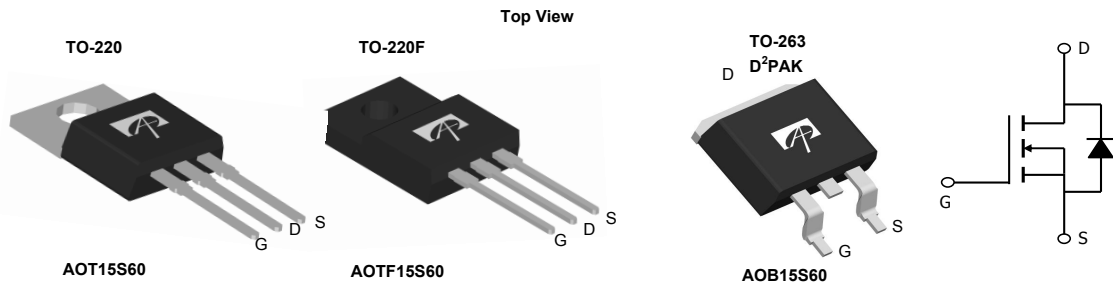
The AOT15S60 & AOB15S60 & AOTF15S60 have been fabricated using the advanced  $\alpha$ MOS™ high voltage process that is designed to deliver high levels of performance and robustness in switching applications. By providing low  $R_{DS(on)}$ ,  $Q_g$  and  $E_{OSS}$  along with guaranteed avalanche capability these parts can be adopted quickly into new and existing offline power supply designs.

For Halogen Free add "L" suffix to part number:  
 AOT15S60L & AOB15S60L & AOTF15S60L

**Product Summary**

|                      |               |
|----------------------|---------------|
| $V_{DS} @ T_{j,max}$ | 700V          |
| $I_{DM}$             | 63A           |
| $R_{DS(ON),max}$     | 0.29 $\Omega$ |
| $Q_{g,typ}$          | 16nC          |
| $E_{OSS} @ 400V$     | 3.6 $\mu$ J   |

100% UIS Tested  
 100%  $R_g$  Tested


**Absolute Maximum Ratings  $T_A=25^\circ\text{C}$  unless otherwise noted**

| Parameter   | Symbol         | AOT15S60/AOB15S60               | AOTF15S60L | Units            |
|---|----------------|---------------------------------|------------|------------------|
| Drain-Source Voltage  | $V_{DS}$       | 600                             |            | V                |
| Gate-Source Voltage   | $V_{GS}$       | $\pm 30$                        |            | V                |
| Continuous Drain Current  | $I_D$          | $T_C=25^\circ\text{C}$          | 15         | 15*              |
|   |                | $T_C=100^\circ\text{C}$         | 10         | 10*              |
| Pulsed Drain Current <sup>C</sup>   | $I_{DM}$       | 63                              |            | A                |
| Avalanche Current <sup>C</sup>  | $I_{AR}$       | 2.4                             |            | A                |
| Repetitive avalanche energy <sup>C</sup>  | $E_{AR}$       | 86                              |            | mJ               |
| Single pulsed avalanche energy <sup>G</sup>   | $E_{AS}$       | 173                             |            | mJ               |
| Power Dissipation <sup>B</sup>  | $P_D$          | $T_C=25^\circ\text{C}$          | 208        | 27.8             |
|   |                | Derate above $25^\circ\text{C}$ | 1.67       | 0.22             |
| MOSFET dv/dt ruggedness   | dv/dt          |                                 | 100        | V/ns             |
| Peak diode recovery dv/dt <sup>H</sup>  |                |                                 | 20         |                  |
| Junction and Storage Temperature Range  | $T_J, T_{STG}$ | -55 to 150                      |            | $^\circ\text{C}$ |
| Maximum lead temperature for soldering purpose, 1/8" from case for 5 seconds <sup>J</sup> | $T_L$          | 300                             |            | $^\circ\text{C}$ |

**Thermal Characteristics**

| Parameter                                  | Symbol          | AOT15S60/AOB15S60 | AOTF15S60L | Units                     |
|--|-----------------|-------------------|------------|---------------------------|
| Maximum Junction-to-Ambient <sup>A,D</sup> | $R_{\theta JA}$ | 65                | 65         | $^\circ\text{C}/\text{W}$ |
| Maximum Case-to-sink <sup>A</sup>          | $R_{\theta CS}$ | 0.5               | --         | $^\circ\text{C}/\text{W}$ |
| Maximum Junction-to-Case                   | $R_{\theta JC}$ | 0.6               | 4.5        | $^\circ\text{C}/\text{W}$ |

\* Drain current limited by maximum junction temperature.

**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter   | Conditions  | Min | Typ   | Max  | Units |
|-----------------------------|---|---|-----|-------|------|-------|
| <b>STATIC PARAMETERS</b>    |   |   |     |       |      |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage                            | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C                          | 600 | -     | -    | V     |
|                             |   | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V, T <sub>J</sub> =150°C                         | 650 | 700   | -    |       |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current                           | V <sub>DS</sub> =600V, V <sub>GS</sub> =0V  | -   | -     | 1    | μA    |
|                             |   | V <sub>DS</sub> =480V, T <sub>J</sub> =150°C  | -   | 10    | -    |       |
| I <sub>GSS</sub>            | Gate-Body leakage current                                 | V <sub>DS</sub> =0V, V <sub>GS</sub> =±30V  | -   | -     | ±100 | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                                    | V <sub>DS</sub> =5V, I <sub>D</sub> =250μA  | 2.5 | 3.2   | 3.8  | V     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance                         | V <sub>GS</sub> =10V, I <sub>D</sub> =7.5A, T <sub>J</sub> =25°C                          | -   | 0.254 | 0.29 | Ω     |
|                             |   | V <sub>GS</sub> =10V, I <sub>D</sub> =7.5A, T <sub>J</sub> =150°C                         | -   | 0.68  | 0.78 | Ω     |
| V <sub>SD</sub>             | Diode Forward Voltage                                     | I <sub>S</sub> =7.5A, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C                           | -   | 0.83  | -    | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current                     |   | -   | -     | 15   | A     |
| I <sub>SM</sub>             | Maximum Body-Diode Pulsed Current <sup>C</sup>            |   | -   | -     | 63   | A     |
| <b>DYNAMIC PARAMETERS</b>   |   |   |     |       |      |       |
| C <sub>ISS</sub>            | Input Capacitance   | V <sub>GS</sub> =0V, V <sub>DS</sub> =100V, f=1MHz  | -   | 717   | -    | pF    |
| C <sub>OSS</sub>            | Output Capacitance  |   | -   | 58    | -    | pF    |
| C <sub>o(er)</sub>          | Effective output capacitance, energy related <sup>H</sup> | V <sub>GS</sub> =0V, V <sub>DS</sub> =0 to 480V, f=1MHz                                   | -   | 41.2  | -    | pF    |
| C <sub>o(tr)</sub>          | Effective output capacitance, time related <sup>I</sup>   |   | -   | 125.2 | -    | pF    |
| C <sub>rSS</sub>            | Reverse Transfer Capacitance                              | V <sub>GS</sub> =0V, V <sub>DS</sub> =100V, f=1MHz  | -   | 1.3   | -    | pF    |
| R <sub>g</sub>              | Gate resistance   | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz  | -   | 13.4  | -    | Ω     |
| <b>SWITCHING PARAMETERS</b> |   |   |     |       |      |       |
| Q <sub>g</sub>              | Total Gate Charge   | V <sub>GS</sub> =10V, V <sub>DS</sub> =480V, I <sub>D</sub> =7.5A                         | -   | 15.6  | -    | nC    |
| Q <sub>gs</sub>             | Gate Source Charge  |   | -   | 3.5   | -    | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge   |   | -   | 6.0   | -    | nC    |
| t <sub>D(on)</sub>          | Turn-On Delay Time  | V <sub>GS</sub> =10V, V <sub>DS</sub> =400V, I <sub>D</sub> =7.5A,<br>R <sub>G</sub> =25Ω | -   | 24.5  | -    | ns    |
| t <sub>r</sub>              | Turn-On Rise Time   |   | -   | 22    | -    | ns    |
| t <sub>D(off)</sub>         | Turn-Off Delay Time                                       |   | -   | 84    | -    | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time  |   | -   | 24    | -    | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time                          | I <sub>F</sub> =7.5A, di/dt=100A/μs, V <sub>DS</sub> =400V                                | -   | 282   | -    | ns    |
| I <sub>rm</sub>             | Peak Reverse Recovery Current                             | I <sub>F</sub> =7.5A, di/dt=100A/μs, V <sub>DS</sub> =400V                                | -   | 26    | -    | A     |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge                        | I <sub>F</sub> =7.5A, di/dt=100A/μs, V <sub>DS</sub> =400V                                | -   | 4.5   | -    | μC    |

A. The value of R<sub>θJA</sub> is measured with the device in a still air environment with T<sub>A</sub>=25°C.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150°C, Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub>=25°C.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150°C. The SOA curve provides a single pulse rating.

G. L=60mH, I<sub>AS</sub>=2.4A, V<sub>DD</sub>=150V, Starting T<sub>J</sub>=25°C

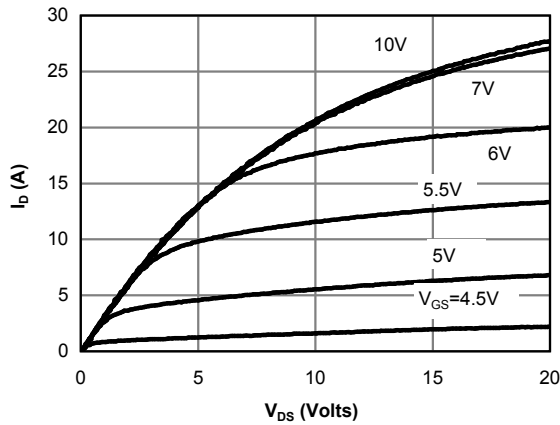
H. C<sub>o(er)</sub> is a fixed capacitance that gives the same stored energy as C<sub>OSS</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>(BR)DSS</sub>.

I. C<sub>o(tr)</sub> is a fixed capacitance that gives the same charging time as C<sub>OSS</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>(BR)DSS</sub>.

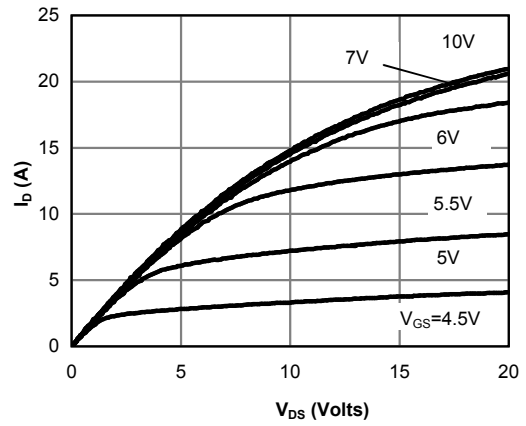
J. Wavesoldering only allowed at leads.

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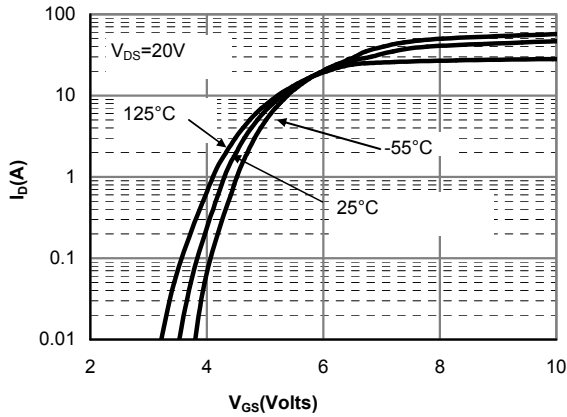
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



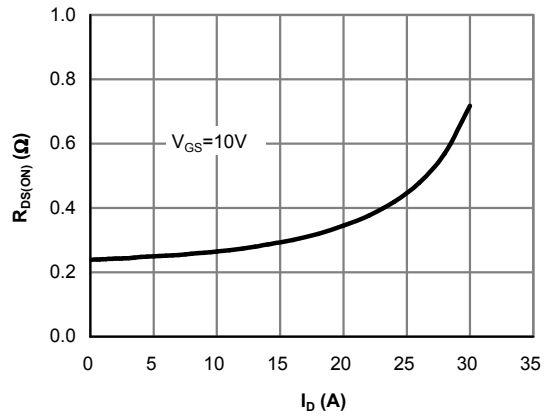
**Figure 1: On-Region Characteristics@25°C**



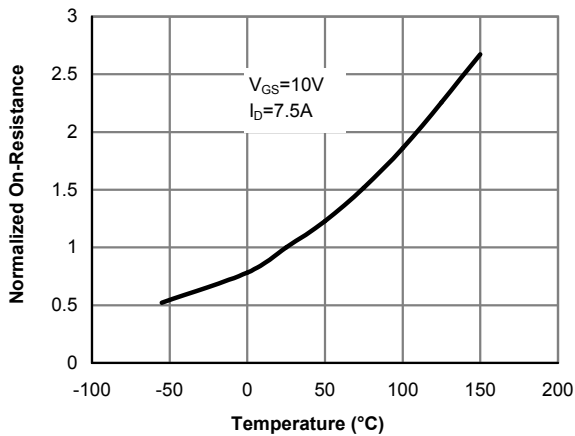
**Figure 2: On-Region Characteristics@125°C**



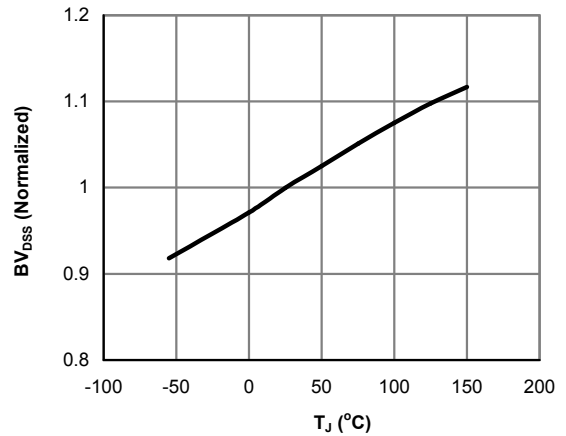
**Figure 3: Transfer Characteristics**



**Figure 4: On-Resistance vs. Drain Current and Gate Voltage**

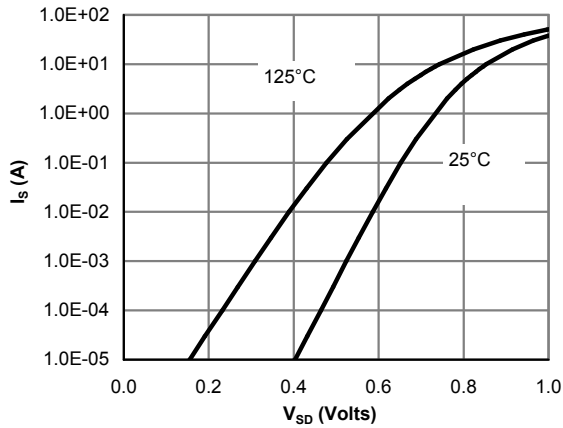


**Figure 5: On-Resistance vs. Junction Temperature**

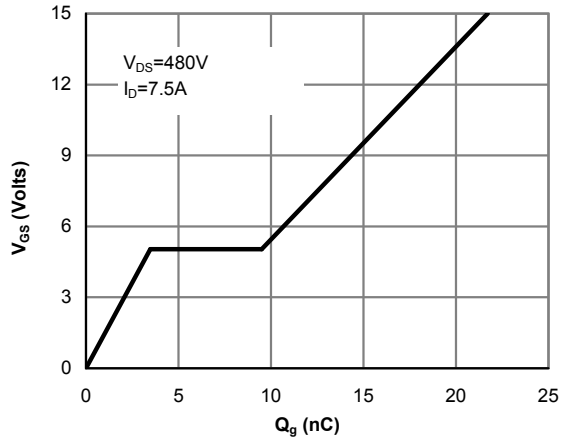


**Figure 6: Break Down vs. Junction Temperature**

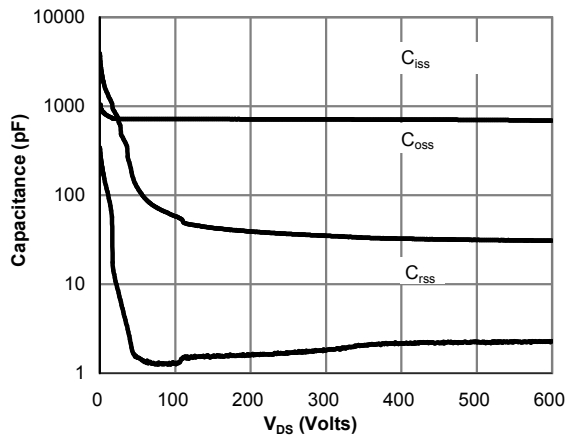
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



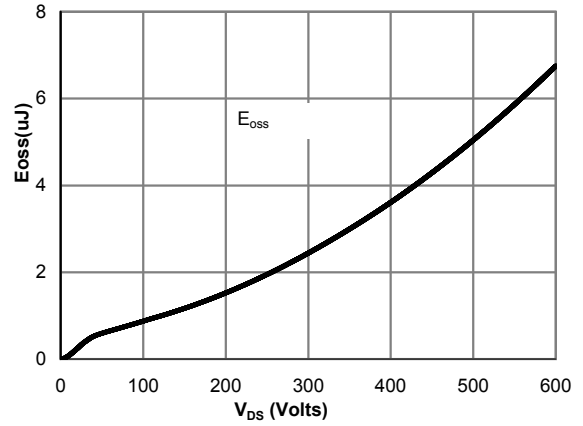
**Figure 7: Body-Diode Characteristics (Note E)**



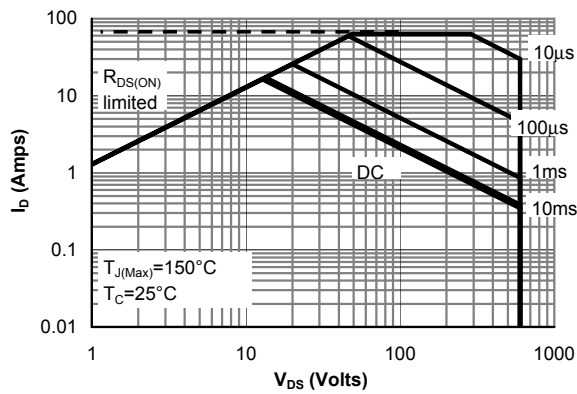
**Figure 8: Gate-Charge Characteristics**



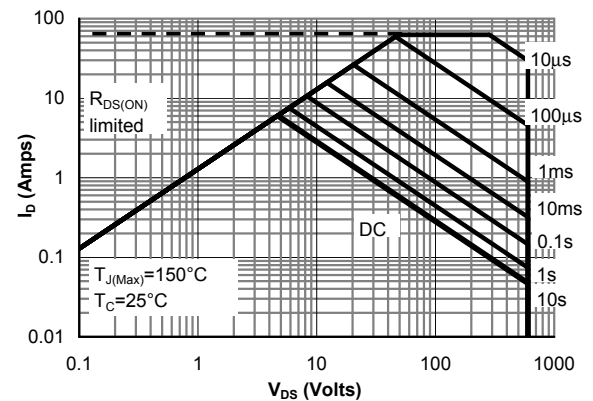
**Figure 9: Capacitance Characteristics**



**Figure 10: Coss stored Energy**



**Figure 11: Maximum Forward Biased Safe Operating Area for AOT(B)15S60 (Note F)**



**Figure 12: Maximum Forward Biased Safe Operating Area for AOTF15S60L (Note F)**

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

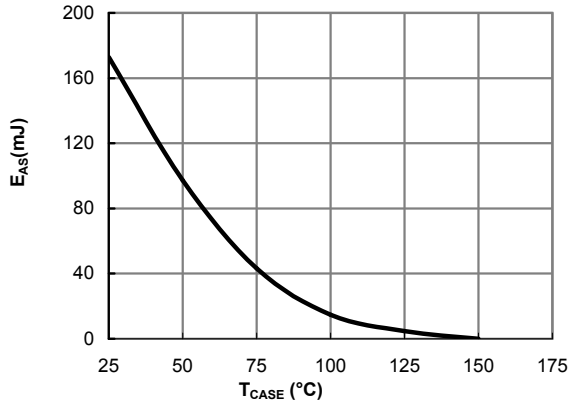


Figure 13: Avalanche energy

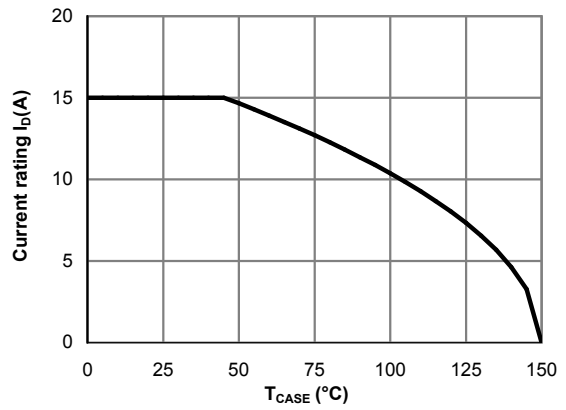


Figure 14: Current De-rating (Note B)

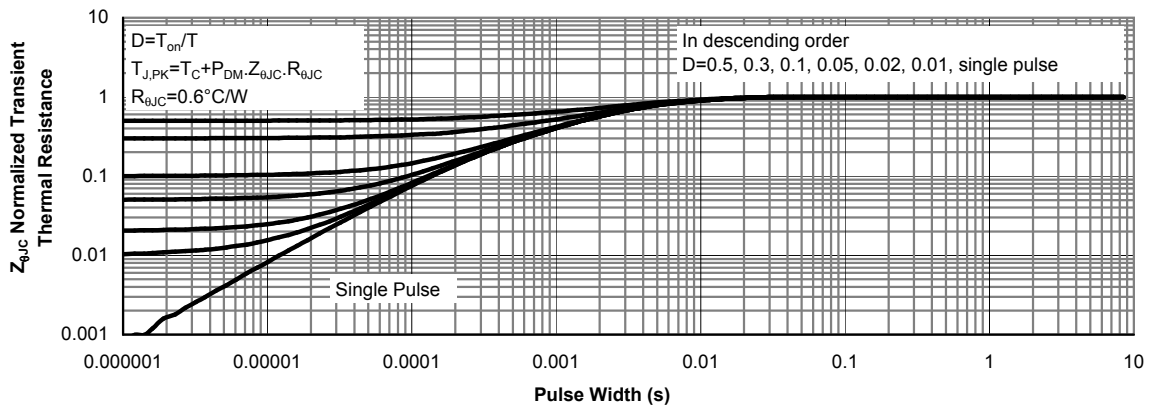


Figure 15: Normalized Maximum Transient Thermal Impedance for AOT(B)15S60 (Note F)

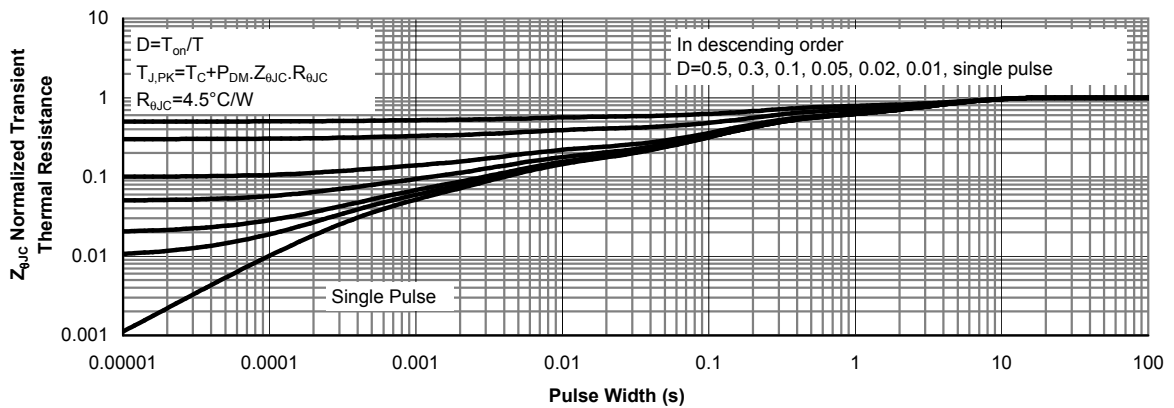
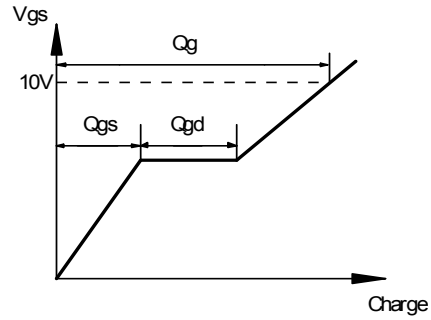
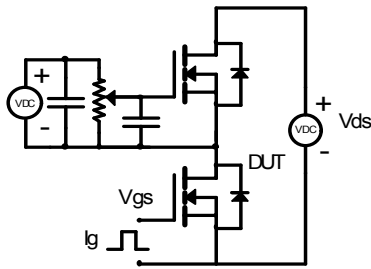
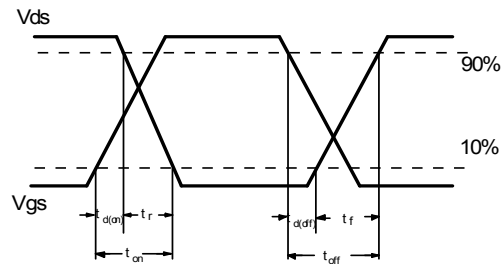
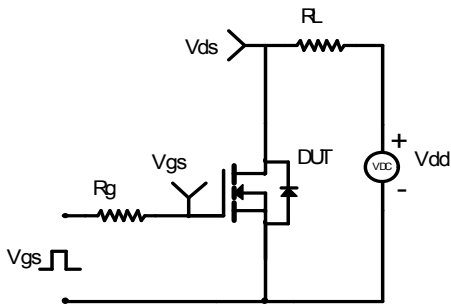


Figure 16: Normalized Maximum Transient Thermal Impedance for AOTF15S60L (Note F)

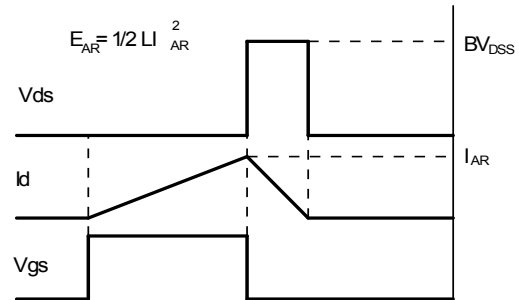
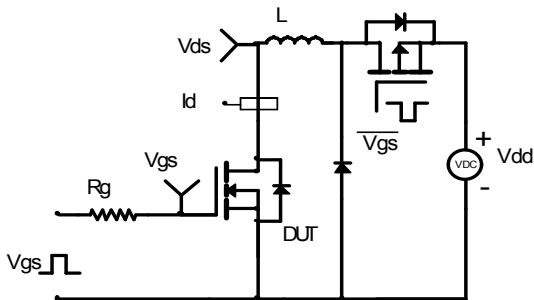
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

